

Y-0020 - 02
ADVANCED LEVEL DIGITAL ELECTRONICS TRAINING SET



The Advanced Digital Electronics Training Set is designed for advanced electronics applications. Set consists of a breadboard that allows internal applications, power supply, oscillator, logic level generator, logic level indicators, dot matrix display and 7 segment display.

2 mm sockets and 2 mm connection leads in different colors are used in the set.

The set is placed with cover in a shock proof separable case. It is designed for using horizontally and is suitable for storing vertically.

The theory, application areas, the definition of the components and their figures in practice are given detailed in introduction of every subject in the Experiment Book. The Book contains the chapters of "Preparation information" supported with circuit diagrams and graphics, "how to do the experiment" where the real pictures are used and "conclusion" where the results and the questions regarding the experiment are included.

TECHNICAL SPECIFICATIONS

Supply Voltage	:	220V AC / 50Hz \pm 10%
DC Fixed TTL Power Supply	:	+5V DC / 1.2A / Electronic protected
TTL Pulse Generator	:	1Hz - 20KHz, Variable
Pulse Switch	:	Positive and Negative



APPLICATION COMPONENTS ON THE SET

Binary switch (with LED Indicator), 12 Bit, TTL	1 Pcs
8 Bit Logic indicator	1 Pcs
BreadBoard (For internal applications)	1 Pcs

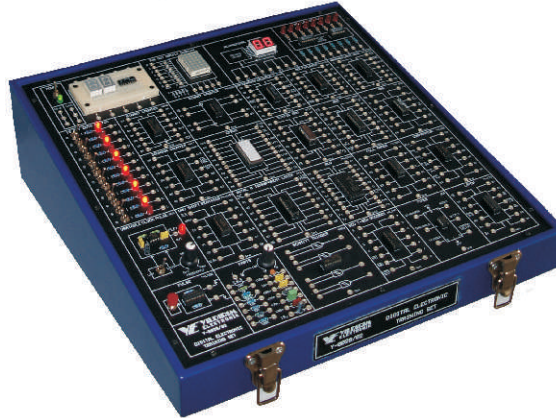


SYSTEM PRESENTATION

Main Unit	:	1 Pcs, (Dimensions 400mm x 45 - 120mm x 420mm)
	:	Metal Case
2mm connection Leads	:	24 Pcs, in 4 different colors
Power Cable	:	1 Pcs, IEC, 2mE
Experiment Book	:	1 Pcs



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PRACTICAL EXPERIMENTS ON ADVANCED LEVEL DIGITAL ELECTRONICS TRAINING SET

- SCHMITT TRIGGER Gate Circuits
- UNIVERSAL SHIFT REGISTER Experiment
 - Left-Shift Register Experiment
 - Parallel Input - Parallel Output Shift Register
 - Complement Shift Register Experiment
- Forming Hexadecimal numbers using 7 segment Display
- Using 7 segment display as Hexadecimal decoder
- Using character generators and dot matrix to generate scrolling writings
 - Examination of Decade Johnson Counter IC
 - Frequency division using one of the FF forming the Binary Counter
 - Forming 3 bit counter using two of the FF forming the Binary Counter
 - Examination of Binary Counter as BCD Counter
 - Examination of 74 LS 93 IC as Binary Counter
 - Up / Down BCD Counter
 - Programming BCD Counter and operation
 - Examination the automatic loading of BCD Counter
 - Examination of up-asynchronous counters composed of JK FF
 - Examination of down-asynchronous counters composed of JK FF
 - Determining the counting range of the asynchronous counters
 - Examination of up-synchronous counters composed of JK FF
 - Examination of down-synchronous counters composed of JK FF
 - Changing the counting limit of synchronous counter
 - Examination of 4040 counter integrated circuit
 - Experiment of counting up to 99
 - 555 timer operating as Astable multivibrator
 - 555 timer operating as Monostable multivibrator
 - Examination of Full Adder
 - Using 74 LS 83 as half adder or half subtractor via MOD selection property
 - Examination of Latch
 - Examination of 74 LS 373 (D-type transparent latch) Integrated Circuit
 - Examination of Comparator Circuits
 - Examination of 74LS47 7 segment decoder circuit
 - Examination of 74LS151 Multiplexer Integrated circuit
 - Examination of 74 LS 259 Integrated Circuit as demultiplexer
 - Examination of AD558 Digital-Analog Converter
 - Examination of ADC0804 Analog-Digital Converter
 - Examination of ADC0804 behaviour after conversion
 - Examination of converting Analog data to digital data and transmitting
 - Examination of 2114 RAM integrated circuit
 - Examination of 2716 EPROM IC addressing experiment
 - Examination of 2716 EPROM IC addressing with 4040 counter
 - Examination of ALU experiments done with 74LS181 IC
 - Counter design with Karnaugh maps
 - Examination of Encoder circuits